


<b>Search Notes</b>  	<b>Application/Control No.</b>  10586996	<b>Applicant(s)/Patent Under Reexamination</b>  MIYASAKA ET AL.
	<b>Examiner</b>  HIEN X VO	<b>Art Unit</b>  2863

SEARCHED			
Class	Subclass	Date	Examiner
702	33-35/113/183/185	05/08/10	VXH
318	806	05/08/10	VXH
	updated search above	8/13/10	VXH
702	66	08/13/10	VXH
73	593/650-660	08/13/10	VXH

SEARCH NOTES		
Search Notes	Date	Examiner
PLUS	02/26/10	VXH
consulted with John Le (primary AU 2863)	05/06/10	VXH
EAST	05/08/10	VXH
inventors search	05/08/10	VXH
PLUS	08/13/10	VXH
EAST	08/13/10	VXH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
702	33/35/113/183/185/66	08/13/10	VXH
73	593/659/660	08/13/10	VXH

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